

## N-Channel 550 V (D-S) Super Junction MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V) at T <sub>J</sub> max.	550				
R <sub>DS(on)</sub> (Ω) at 25 °C	$V_{GS} = 10 V$	0.4			
Q <sub>g</sub> max. (nC)	106				
Q <sub>gs</sub> (nC)	14				
Q <sub>gd</sub> (nC)	33				
Configuration	Single				

#### **FEATURES**

- Reduced t<sub>rr</sub>, Q<sub>rr</sub>, and I<sub>RRM</sub>
- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (Ciss)
- Low switching losses due to reduced Q<sub>rr</sub>
- Ultra low gate charge (Q<sub>a</sub>)
- Avalanche energy rated (UIS)

#### **APPLICATIONS**

- Telecommunications
- Server and telecom power supplies
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Consumer and computing - ATX power supplies
- Industrial
  - Welding
  - Battery chargers
- Renewable energy
- Solar (PV inverters)
- Switch mode power supplies (SMPS)

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_c = 25 \degree C$ , unless otherwise noted)									
PARAMETER			SYMBOL	LIMIT	UNIT				
Drain-Source Voltage		V <sub>DS</sub>	550						
Gate-Source Voltage			V <sub>GS</sub>	± 30	V				
Continuous Drain Current ( $T_J = 150 \ ^{\circ}C$ )	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C T <sub>C</sub> = 100 °C		13					
	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	ID	9	А				
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	60					
Linear Derating Factor				1.7	W/°C				
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	310	mJ				
Maximum Power Dissipation			P <sub>D</sub>	188	W				
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C					
Drain-Source Voltage Slope	T <sub>J</sub> = 125 °C			37	N//				
Reverse Diode dV/dt <sup>d</sup>		dV/dt	31	V/ns					
Soldering Recommendations (Peak Temperature) <sup>c</sup>	for 10 s			300	°C				

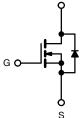
#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD} = 50$  V, starting T<sub>J</sub> = 25 °C, L = 28.2 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 5.1 A.

c. 1.6 mm from case.

d.  $I_{SD} \leq I_D$ , dl/dt = 100 A/µs, starting  $T_J$  = 25 °C.





N-Channel MOSFET





THERMAL RESISTANCE RAT	NGS								
PARAMETER	SYMBOL	TYP.		MAX.		UNIT			
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		62					
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 0.5				°C/W			
SPECIFICATIONS (T <sub>J</sub> = 25 $^{\circ}$ C, u	unless otherwi	ise noted)							
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT	
Static		<u>.</u>							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	= 0 V, I <sub>D</sub> =	250 µA	550	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C	, I <sub>D</sub> = 1 mA	-	0.67	-	V/°C	
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> =	250 µA	2	-	4	V	
Cata Sauraa Laakaga			$V_{GS} = \pm 20 V$ $V_{GS} = \pm 30 V$		-	-	± 100	nA	
Gate-Source Leakage	I <sub>GSS</sub>				-	-	± 1	μA	
Zero Gate Voltage Drain Current	1-	V <sub>DS</sub> =	= 550 V, V <sub>0</sub>	<sub>as</sub> = 0 V	-	-	1		
	IDSS	V <sub>DS</sub> = 550 \	$V, \overline{V_{GS}} = 0$	V, T <sub>J</sub> = 125 °C	-	-	500	μA	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V		l <sub>D</sub> = 11 A	-	0.4	-	Ω	
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub>	= 30 V, I <sub>D</sub>	= 11 A	-	7.0	-	S	
Dynamic					•	•	•	•	
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 100 V, f = 1 MHz		-	2132	-	pF	
Output Capacitance	C <sub>oss</sub>				-	105	-		
Reverse Transfer Capacitance	C <sub>rss</sub>				-	4	-		
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>				-	84	-		
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>	$V_{DS}$ = 0 V to 520 V, $V_{GS}$ = 0 V		-	293	-			
Total Gate Charge	Q <sub>g</sub>				-	71	106		
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 \text{ V}$ $I_D = 11 \text{ A}, V_{DS} = 520 \text{ V}$		-	14	-	nC		
Gate-Drain Charge	Q <sub>gd</sub>				-	33	-	1	
Turn-On Delay Time	t <sub>d(on)</sub>		$V_{DD}$ = 520 V, I <sub>D</sub> = 11 A, V <sub>GS</sub> = 10 V, R <sub>g</sub> = 9.1 Ω		-	22	44	- ns	
Rise Time	t <sub>r</sub>	- V <sub>DD</sub> =			-	34	68		
Turn-Off Delay Time	t <sub>d(off)</sub>	V <sub>GS</sub> :			-	68	102		
Fall Time	t <sub>f</sub>	1		-	42	84	1		
Gate Input Resistance	R <sub>g</sub>	f = 1 MHz, open drain		-	0.78	-	Ω		
Drain-Source Body Diode Characteristi	cs								
Continuous Source-Drain Diode Current	١ <sub>S</sub>	MOSFET sym showing the	MOSFET symbol showing the		-	-	13	_	
Pulsed Diode Forward Current	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	50	A		
Diode Forward Voltage	V <sub>SD</sub>	T <sub>.1</sub> = 25 °	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 11 A, V <sub>GS</sub> = 0 V		-	0.9	1.2	V	
Reverse Recovery Time	t <sub>rr</sub>		T <sub>J</sub> = 25 °C, I <sub>F</sub> = I <sub>S</sub> = 11 A,		-	160	-	ns	
Reverse Recovery Charge	Q <sub>rr</sub>				-	1.2	-	μC	
Reverse Recovery Current	I <sub>RRM</sub>	dl/dt = 100 A/µs, V <sub>R</sub> = 25 V		-	14	-	A		

#### Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

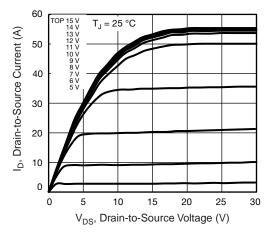


Fig. 1 - Typical Output Characteristics

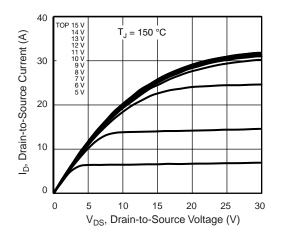


Fig. 2 - Typical Output Characteristics

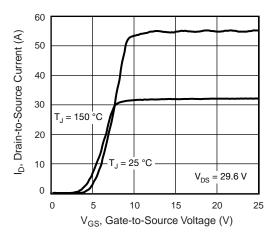


Fig. 3 - Typical Transfer Characteristics

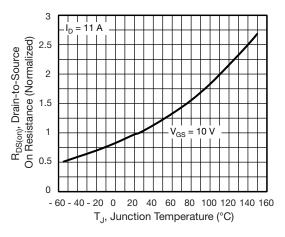


Fig. 4 - Normalized On-Resistance vs. Temperature

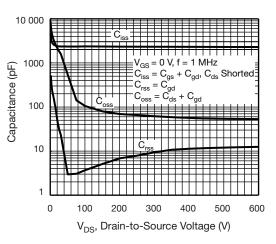


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

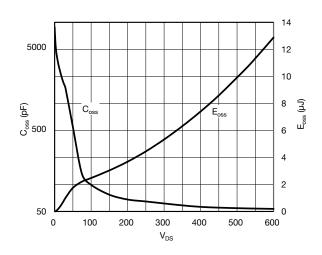


Fig. 6 -  $C_{oss}$  and  $E_{oss}$  vs.  $V_{DS}$ 

## VBL155R13



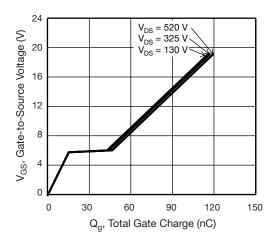


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

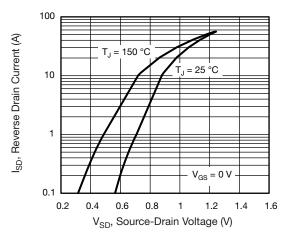


Fig. 8 - Typical Source-Drain Diode Forward Voltage

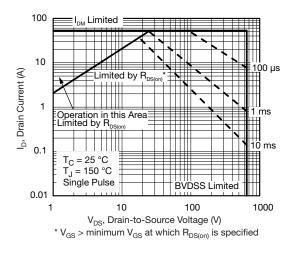


Fig. 9 - Maximum Safe Operating Area

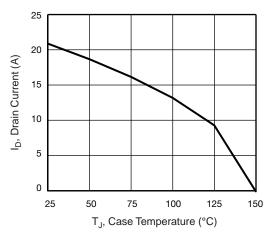


Fig. 10 - Maximum Drain Current vs. Case Temperature

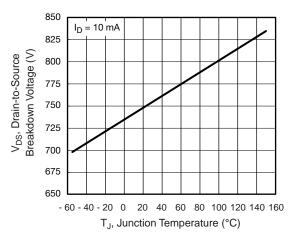


Fig. 11 - Temperature vs. Drain-to-Source Voltage



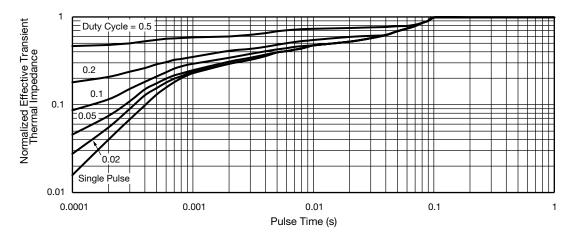


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

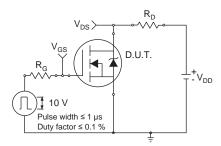


Fig. 13 - Switching Time Test Circuit

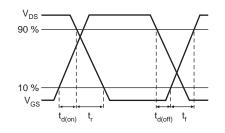


Fig. 14 - Switching Time Waveforms

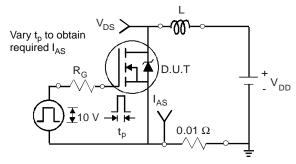


Fig. 15 - Unclamped Inductive Test Circuit

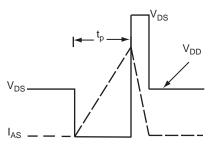


Fig. 16 - Unclamped Inductive Waveforms

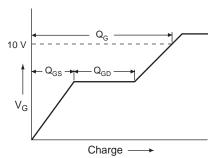
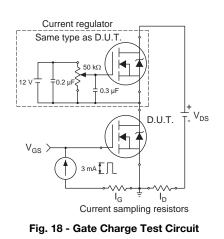
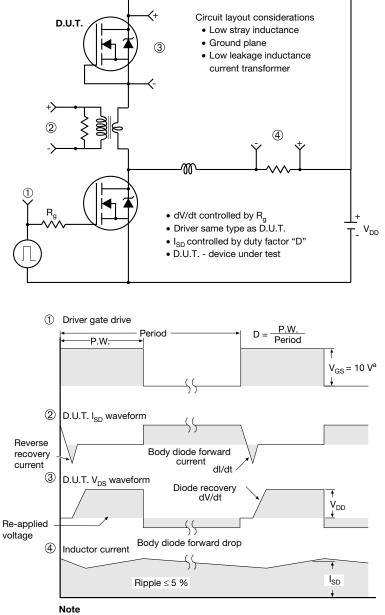


Fig. 17 - Basic Gate Charge Waveform





Peak Diode Recovery dV/dt Test Circuit

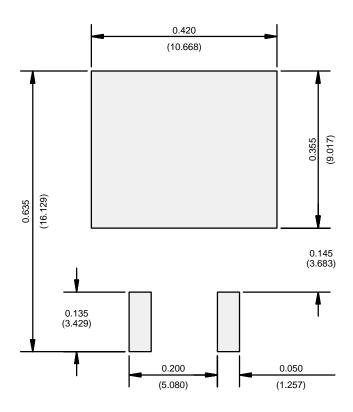


a.  $V_{GS} = 5$  V for logic level devices

Fig. 19 - For N-Channel



## **RECOMMENDED MINIMUM PADS FOR D<sup>2</sup>PAK: 3-Lead**



Recommended Minimum Pads Dimensions in Inches/(mm)



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